

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Inventor(s) : HIROSHI SAKAYORI  
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Title : APPARATUS FOR TESTING INTEGRATED CIRCUITS  
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Mail Stop APPLICATION  
Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

**PRELIMINARY AMENDMENT**

Dear Sir:

Prior to examination of the above-noted divisional patent application filed herewith, please enter the following amendment.

**Amendments to the Specification** begin on page 2 of this paper.

**Amendments to the Claims** begin on page 3 of this paper.

**Amendments to the Drawings** begin on page 5 of this paper.

**Remarks** begin on page 6 of this paper.

An **Appendix** including amended drawings, replacement Sheets 1-10, is attached following page of this paper.